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APPLICANT
Belford T. Coursey

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GROUP
2813

LIST OF PRIOR ART CITED BY APPLICANT
(Use separate sheets if necessary)

U.S. PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
YH	AA 6,057,306	05/2000	Nguyen et al.	438/	401	
	AB 6,057,306	05/2000	Tung et al.	438/	092	
	AC 6,130,126	09/2000	Iwakiri	438/	253	
	AD 6,232,168	05/2001	Coursey	438/	241	
	AE 6,030,879	02/2000	Huang et al.	438/	397	
	AF 4,996,627	02/1991	Zias et al.	361/	283	
	AG 5,770,499	06/1998	Kwok et al.	438/	253	
	AH 6,258,729	07/2001	DeBoer et al.	438/	745	
	AI 5,990,021	11/1999	Prall et al.	438/	745	
	AJ 6,200,898	03/2001	To	438/	692	
	AK 6,232,340	05/2001	Tung	438/	745	
YH	AL 6,054,394	04/2000	Wang	438/	753	

FOREIGN PATENT DOCUMENTS

Document Number	Date	Country	Class	Subclass	Translation	
					Yes	No
AM						
AN						
AO						
AP						
AO						

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

AR	E. Fujii, et al., "ULSI DRAM Technology with Ba _{0.8} Sr _{0.2} TiO ₃ Film of 1.3um Equivalent SiO ₂ Thickness and 10 ⁻⁹ A/cm ² Leakage Current" IEEE 1992 IEDM 92-267 - 270.
AS	
AT	

EXAMINER *YH* DATE CONSIDERED 11/7/02

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.